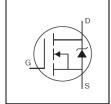
#### **AUTOMOTIVE GRADE**

# AUIRFR1010Z

HEXFET® Power MOSFET

#### **Features**

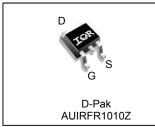
- Advanced Process Technology
- Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>		55V
R <sub>DS(on)</sub>	typ.	$5.8$ m $\Omega$
	max.	7.5m $\Omega$
D (Silicon Lin	nited)	91A
D (Package L	imited)	42A

# Description Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating .

These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide



G	D	S
Gate	Drain	Source

Page part number	Dookogo Typo	Standard Pack	\$	Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFR1010Z	D. Dak	Tube	75	AUIRFR1010Z
AUIRFRIUIUZ	D-Pak	Tape and Reel Left	3000	AUIRFR1010ZTRL

### **Absolute Maximum Ratings**

variety of other applications.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	91	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	65	Α
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	42	
I <sub>DM</sub>	Pulsed Drain Current ①	360	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	140	W
	Linear Derating Factor	0.9	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ②	110	
E <sub>AS</sub> (Tested)	Single Pulse Avalanche Energy Tested Value ®	220	- mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ⑤		mJ
$T_J$	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

#### Thermal Resistance

Symbol Parameter		Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		1.11	
$R_{\theta JA}$	Junction-to-Ambient ( PCB Mount) ⑦		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

2015-11-19

<sup>\*</sup>Qualification standards can be found at www.infineon.com



### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.051		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		5.8	7.5	$m\Omega$	V <sub>GS</sub> = 10V, I <sub>D</sub> = 42A ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 100 \mu A$
gfs	Forward Trans conductance	31			S	$V_{DS} = 25V, I_{D} = 42A$
1	Drain-to-Source Leakage Current			20		$V_{DS} = 55 \text{ V}, V_{GS} = 0 \text{ V}$
I <sub>DSS</sub>	Dialii-10-Source Leakage Current			250	μA	$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
1	Gate-to-Source Forward Leakage			200	n ^	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-200		V <sub>GS</sub> = -20V

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	•	-	-		
$Q_g$	Total Gate Charge	 63	95		I <sub>D</sub> = 42A
$Q_{gs}$	Gate-to-Source Charge	 17		nC	$V_{DS} = 44V$
$Q_{gd}$	Gate-to-Drain Charge	 23			V <sub>GS</sub> = 10V3
$t_{d(on)}$	Turn-On Delay Time	 17			$V_{DD} = 28V$
t <sub>r</sub>	Rise Time	 76			I <sub>D</sub> = 42A
$t_{d(off)}$	Turn-Off Delay Time	 42		ns	$R_G = 7.6\Omega$
t <sub>f</sub>	Fall Time	 48			V <sub>GS</sub> = 10V3
L <sub>D</sub>	Internal Drain Inductance	4.5			Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance	7.5			from package and center of die contact
C <sub>iss</sub>	Input Capacitance	2840			$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	470			$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	250		рF	f = 1.0MHz
$C_{oss}$	Output Capacitance	 1630		PΓ	$V_{GS} = 0V$ , $V_{DS} = 1.0V$ $f = 1.0MHz$
Coss	Output Capacitance	 360			$V_{GS} = 0V$ , $V_{DS} = 44V$ $f = 1.0MHz$
Coss eff.	Effective Output Capacitance	 560			$V_{GS}$ = 0V, $V_{DS}$ = 0V to 44V $\textcircled{4}$

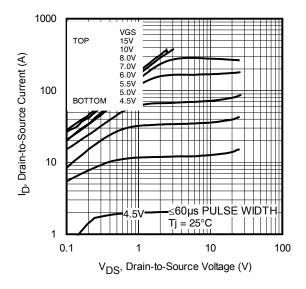
#### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			42	_	MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			360		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 42A, V_{GS} = 0V$ ③
t <sub>rr</sub>	Reverse Recovery Time		24	36	ns	$T_J = 25^{\circ}C$ , $I_F = 42A$ , $V_{DD} = 28V$
$Q_{rr}$	Reverse Recovery Charge		20	30	nC	di/dt = 100A/µs③
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	turn-or	time is	negligil	ole (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25$ °C, L = 0.13mH,  $R_G = 25\Omega$ ,  $I_{AS} = 42$ A,  $V_{GS} = 10$ V. Part not recommended for use above this value.
- $\oplus$  C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>
- © Limited by T<sub>Jmax</sub>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- © This value determined from sample failure population. 100% tested to this value in production.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994





1000

TOP 15V
10V
8.0V
7.0V
6.0V
5.5V
8.0T
10

BOTTOM 4.5V

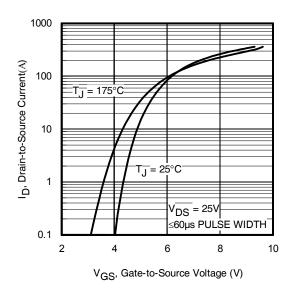
-<60µs PULSE WIDTH
Tj = 175°C

10.1 1 10 100

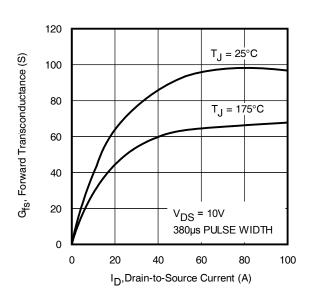
VDS, Drain-to-Source Voltage (V)

Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics

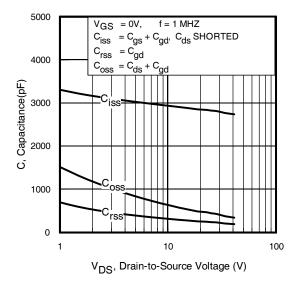




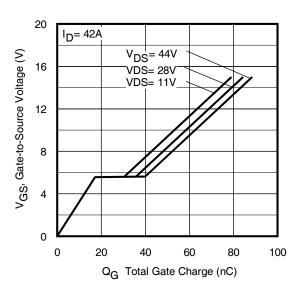


**Fig. 4** Typical Forward Trans conductance Vs. Drain Current





**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

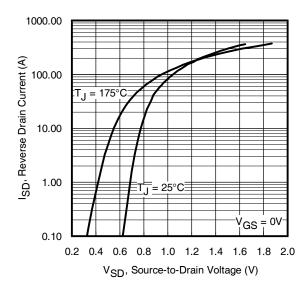


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

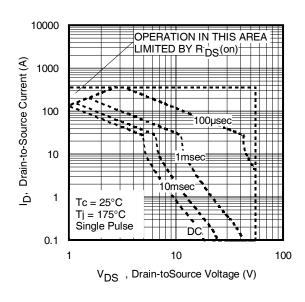
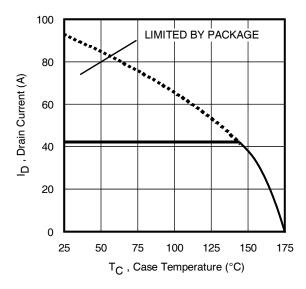
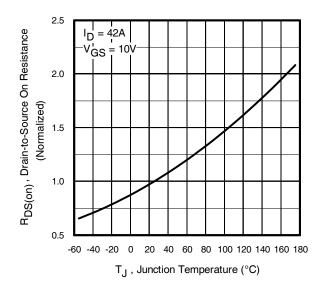


Fig 8. Maximum Safe Operating Area







**Fig 9.** Maximum Drain Current Vs. Case Temperature

**Fig 10.** Normalized On-Resistance Vs. Temperature

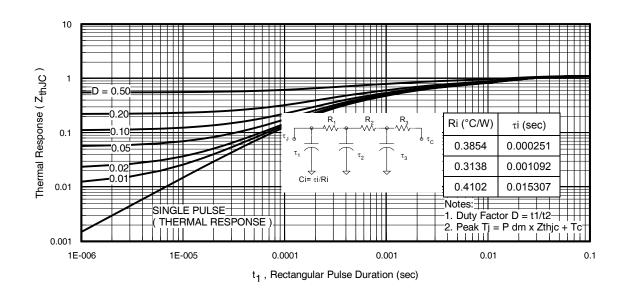


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



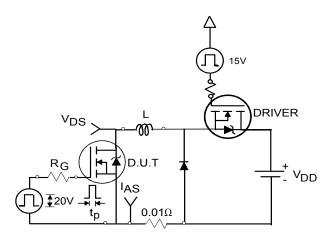


Fig 12a. Unclamped Inductive Test Circuit

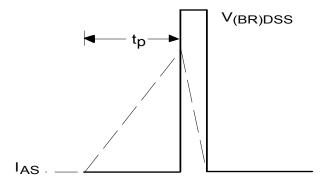


Fig 12b. Unclamped Inductive Waveforms

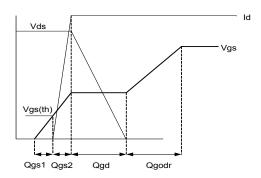


Fig 13a. Gate Charge Waveform

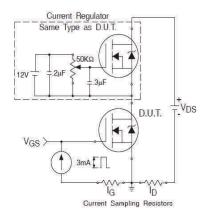
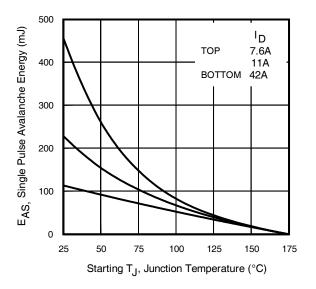


Fig 13b. Gate Charge Test Circuit



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

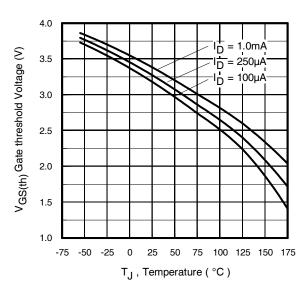


Fig 14. Threshold Voltage Vs. Temperature

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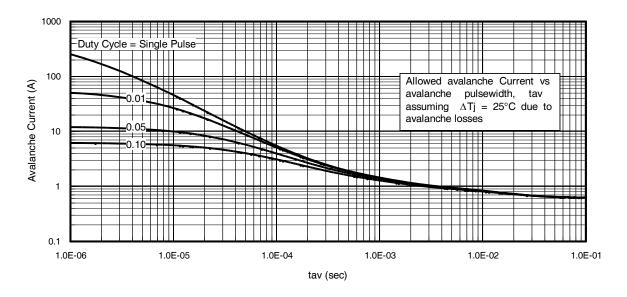
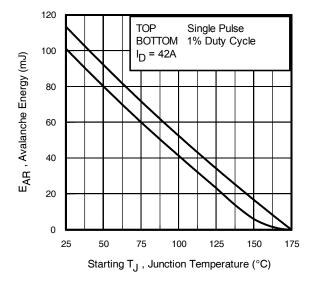


Fig 15. Typical Avalanche Current Vs. Pulse width



**Fig 16.** Maximum Avalanche Energy Vs. Temperature

#### Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>imax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



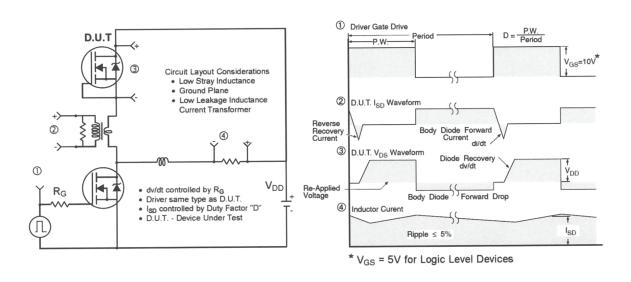


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

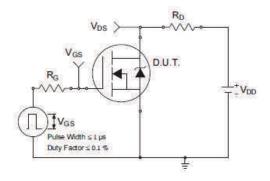


Fig 18a. Switching Time Test Circuit

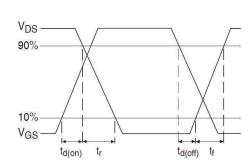
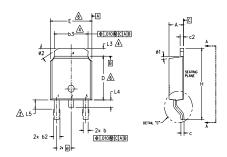


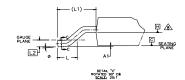
Fig 18b. Switching Time Waveforms

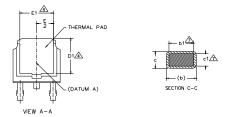


## D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









#### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 1 LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- Limited Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S		N			
M B O	MILLIM	ETERS	INC	HES	O T
O L	MIN.	MAX.	MIN.	MAX.	E S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
Н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0,	10*	0,	10°	
ø1	0.	15*	0,	15*	
ø2	25*	35*	25*	35*	

#### LEAD ASSIGNMENTS

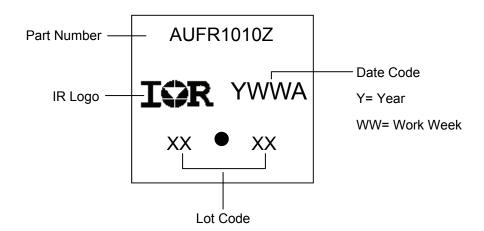
### **HEXFET**

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE 4.- DRAIN

#### IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR

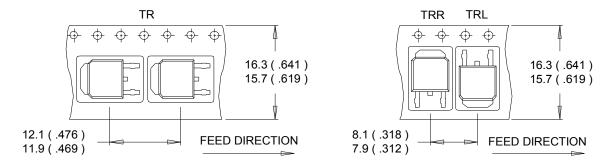
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

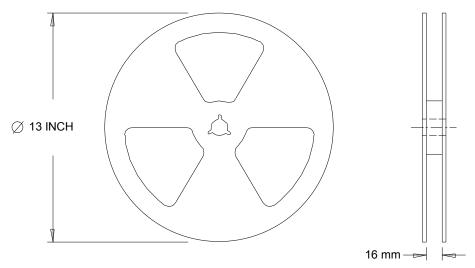


### D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



#### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



### NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



#### **Qualification Information**

		Automotive				
		(per AEC-Q101)  Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture	Sensitivity Level	D-Pak	MSL1			
		Class M4 (+/- 700V) <sup>†</sup>				
	Machine Model	AEC-Q101-002				
FOD	Lluman Dady Madal	Class H1C (+/- 1500V) <sup>†</sup>				
ESD	Human Body Model	AEC-Q101-001				
	Charried Davies Medal	Class C5 (+/- 2000V) <sup>†</sup>				
Charged Device Model		AEC-Q101-005				
RoHS Compliant		Yes				

† Highest passing voltage.

### **Revision History**

Date	Comments			
	Updated datasheet with corporate template			
11/19/2015	Corrected ordering table on page 1.			
	<ul> <li>Corrected RthJA (PCB mount) typo from "40°C/W" to "50°C/W" on page 1.</li> </ul>			

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